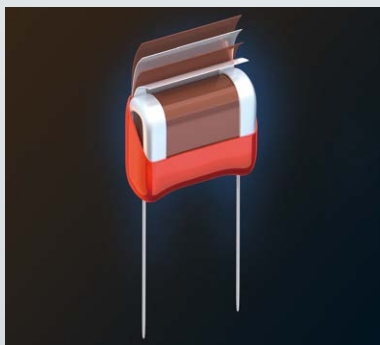
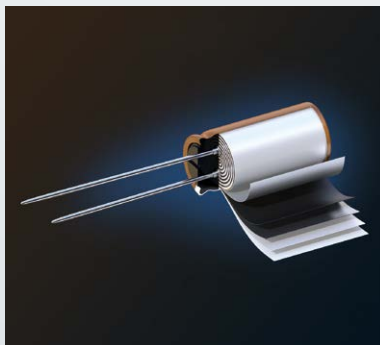
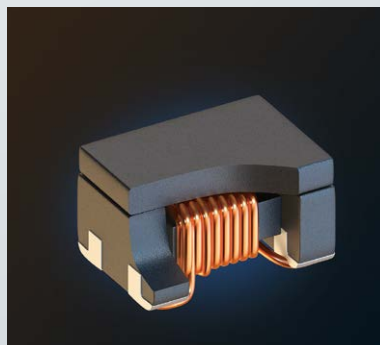
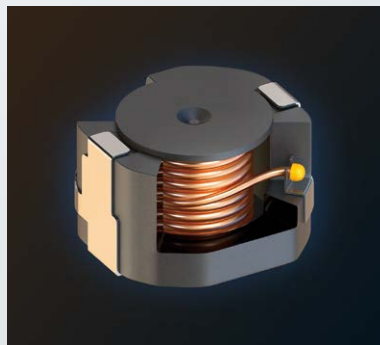
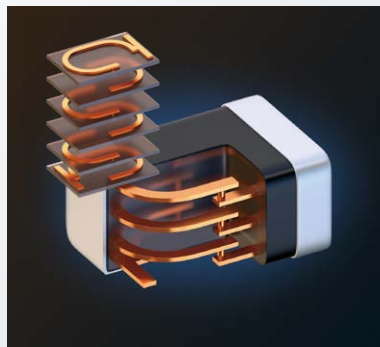


Electrical measurement in electronic component performance evaluation and quality testing

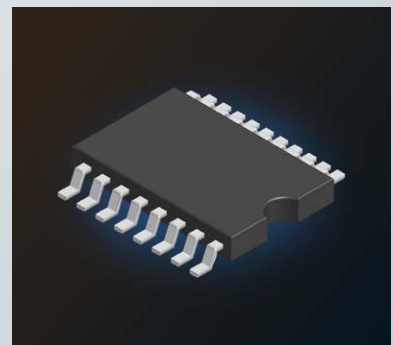
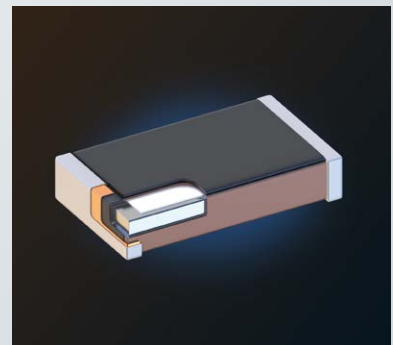
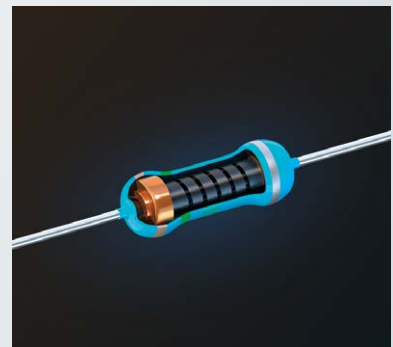
Capacitors



Inductors



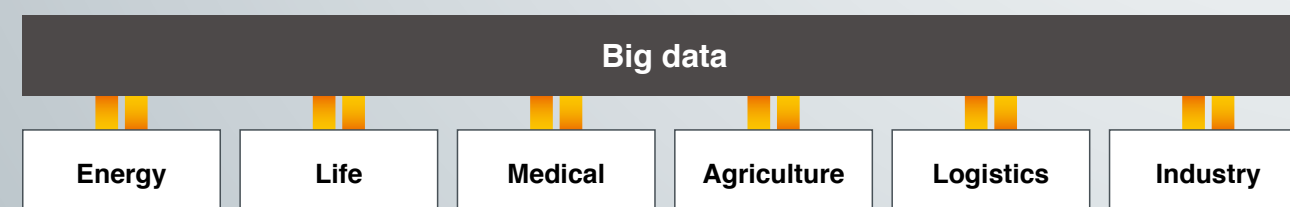
Resistors





Moving towards a sustainable society with digital technology and 5G

Trends are accelerating towards connecting devices with information and using energy efficiently. Innovations in a variety of core functions of society are taking place due to the combination of fast, high-bandwidth data communications based on 5G networks and advanced digital technologies.



Increasingly computerized automobiles



Information and communication between cars (V2X)



Smart factories



Automated shipping services



Data centers that support high-capacity communication



Smart houses for efficient use of electricity



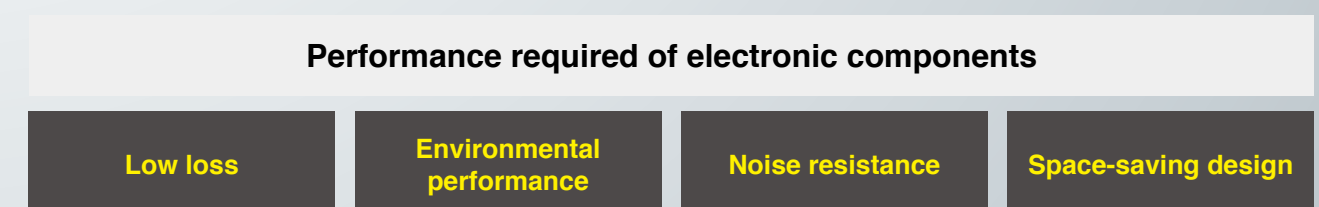
Increasingly sophisticated devices



Growing crops using drones

Electronic components that make possible advanced digital technologies

All digital technologies are supported by highly reliable electric circuits. The performance of electronic components exerts a major influence on the operation of the electric circuits they comprise. In recent days, ensuring electronic components deliver a high level of performance is an essential part of satisfying market requirements.

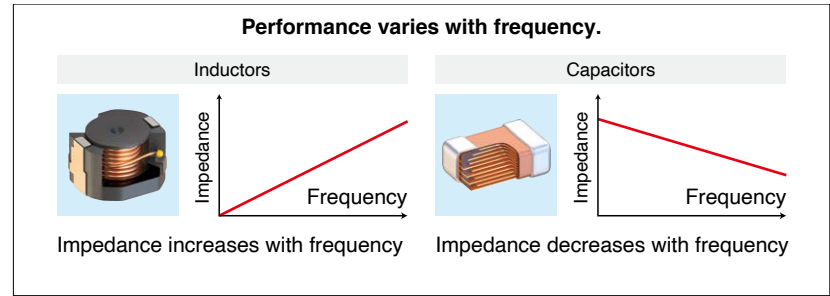


Measuring the performance of electronic components

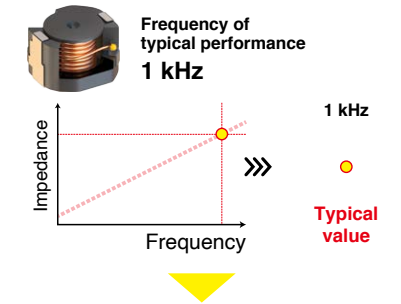
Electric circuits operate properly when electronic components perform as designed. It is possible to design highly reliable circuits by measuring electronic components to accurately assess their performance.

Assessing the performance of electronic components

Electricity frequency affects the performance of electronic components to a significant degree. That makes it important to check the performance of electronic components at the frequencies at which they will actually be used.



Observing representative performance



LCR Meters

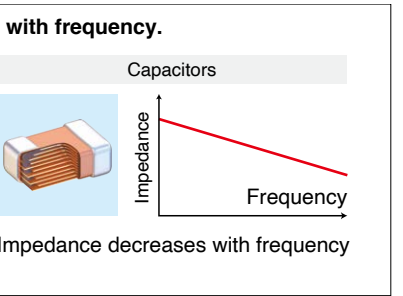
Check the performance of electronic components while applying electricity of particular frequencies

Model	Measurement frequency
IM3533	1 MHz to 200 kHz

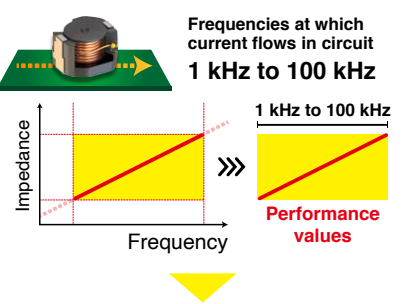
Model	Measurement frequency
IM3536	4 Hz to 8 MHz

Assessing changes in the performance by frequency

Frequency affects the performance of electronic components to a significant degree. That's why it's important to check how the performance of electronic components changes as the frequency changes.



Observing performance under conditions of actual use



Impedance Analyzers

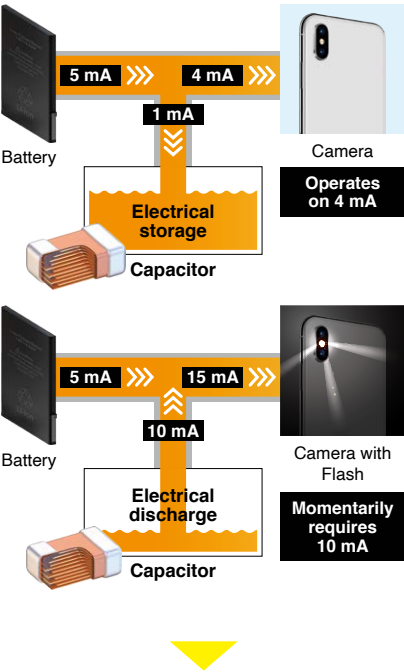
Check the characteristics of electronic components while varying the frequency and signal magnitude.

Model	Measurement frequency
IM7580A	1 MHz to 300 MHz
IM7581	100 kHz to 300 MHz
IM7583	1 MHz to 600 MHz
IM7585	1 MHz to 1.3 GHz
IM7587	1 MHz to 3 GHz

Model	Measurement frequency
IM3570	4 Hz to 5 MHz

Measuring capacitors

Capacitors store and discharge electricity in circuits. The ability to store electricity in this manner is known as capacitance. Various types of capacitors are available, and it's necessary to choose the type that best suits your application.



C Meters

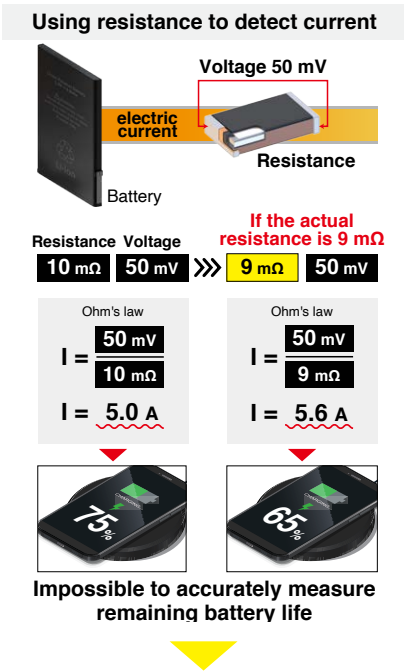
Measure the capacitance of capacitors.

Measurement of large C values	
Model	Capacitance measurement range
3504-40	0.9400 pF to 20.0000 mF
3504-50	0.9400 pF to 20.0000 mF
3504-60	0.9400 pF to 20.0000 mF

Measurement of low C values	
Model	Capacitance measurement range
3506-10	0.001 fF to 15.0000 μF

Measuring resistors

Resistors regulate the amount of electricity flowing in a circuit, and they're used to detect the magnitude of currents. By accurately assessing resistors' resistance value and embedding them in circuits, you can regulate and detect current with a high degree of precision.



Resistance meters

Measure resistance with a high degree of precision.

Low Rdc measurement	
Model	Resistance measurement range
RM3543	0.00000 mΩ to 1200.000 Ω

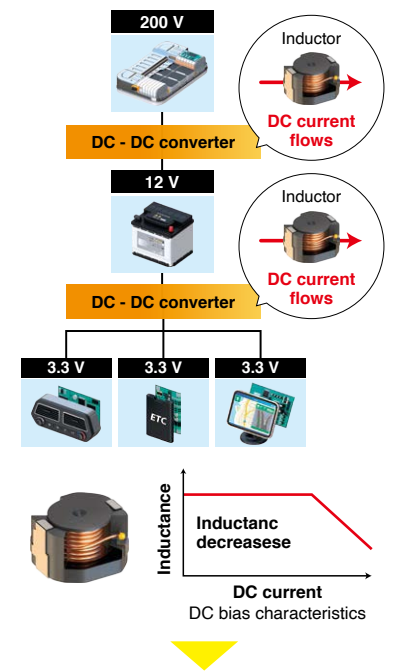
High Rdc measurement	
Model	Resistance measurement range
RM3542A	0.0000 mΩ to 120.0000 MΩ*1

Multichannel pass/fail measurement	
Model	Resistance measurement range
RM3545-02	0.00000 mΩ to 1200.0 MΩ*1

*1: LOW POWER OFF *2: With a Z3003

Checking DC bias characteristics

When a DC current flows to a coil, the circuit's inductance may vary. The resulting tendencies are known as DC bias characteristics.



DC Bias Current Unit LCR Meter

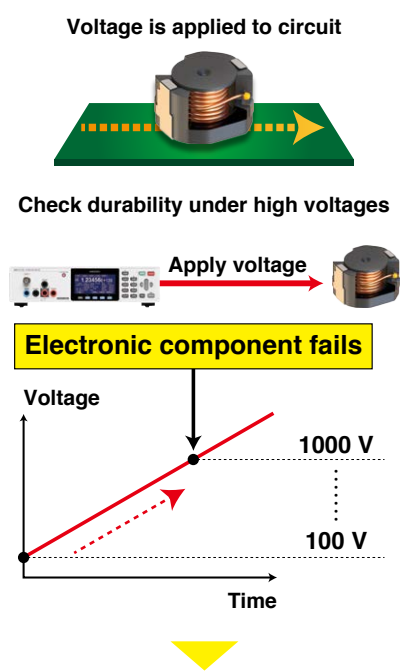
Superpose a DC current from an external power source onto the measurement signal to measure the DC bias characteristics.

Insulation resistance measurement	
Model	Test voltage (DC)
SM7110	0.1 V to 1000.0 V
SM7120	0.1 V to 2000.0 V

Withstand voltage tester	
Model	Test voltage (AC/DC)
3153	0.2 kV to 5.00 kV

Testing durability

Applying a voltage above a certain level to an electronic component will damage the component and cause the device to fail. That's why it's important to check whether the component can withstand the voltage applied by the designed circuit.



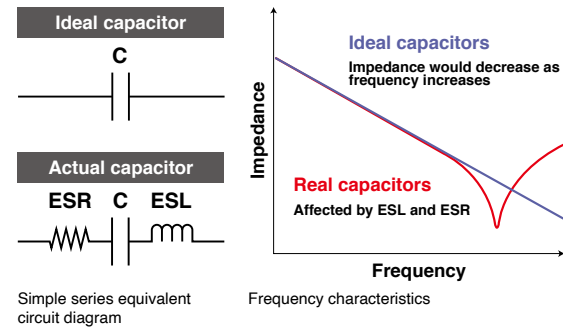
Super Megohm Meters Insulation/withstanding Testers

Check an electronic component's durability by applying a gradually increasing voltage to it.

Insulation resistance measurement	
Model	Test voltage (DC)
SM7110	0.1 V to 1000.0 V
SM7120	0.1 V to 2000.0 V

Withstand voltage tester	
Model	Test voltage (AC/DC)
3153	0.2 kV to 5.00 kV

The figure consists of three panels showing a 3D model of a microfluidic device. The left panel shows the device in a closed state with a white top layer and a red bottom layer. The middle panel shows the device partially open, with the red layer being lifted. The right panel shows the device fully open, with the red layer completely detached and folded back, revealing the internal structure. The device has two thin metal pins extending from the bottom.

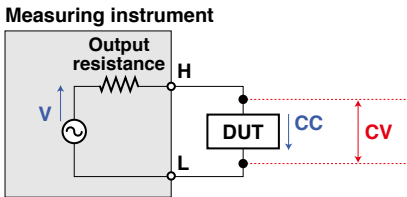
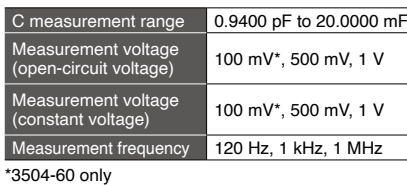
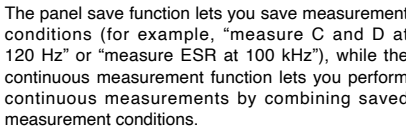
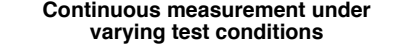
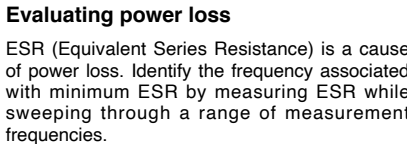
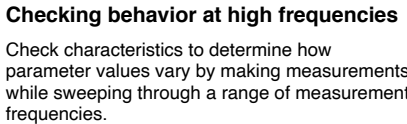
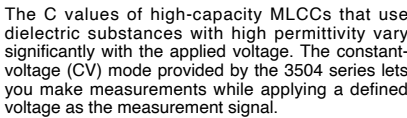
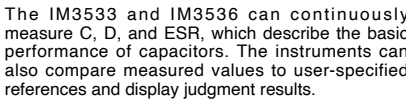
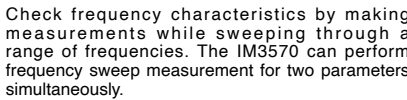


Equivalent series resistance (ESR) and equivalent series inductance (ESL)

An ideal capacitor would be an element that has only capacitance (C). In reality, however, capacitors have ESR (resistance called Equivalent Series Resistance) caused by losses from the dielectric substance, electrodes, and other factors, as well as parasitic ESL (inductance called Equivalent Series Inductance) caused by electrodes, lead wires, and other factors.

Loss coefficient D ($\tan \delta$)

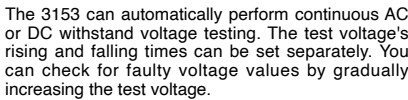
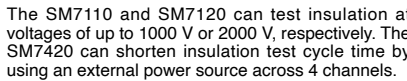
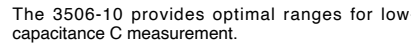
The loss coefficient D ($\tan \delta$) expresses the power loss of a capacitor. Smaller values indicate less power loss, and therefore higher-quality capacitors.



Setting the measurement signal level

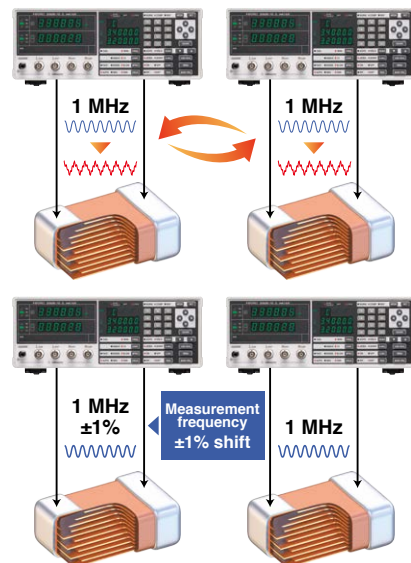
- Open-circuit voltage (V) mode**
Set the voltage produced by the instrument's signal source
- Constant-voltage (CV) mode**
Set the voltage applied to the DUT
This mode is used when measuring components that exhibit voltage dependency, for example a high-permittivity MLCC
- Constant-current (CC) mode***
Set the current that flows to the DUT
This mode is used when measuring devices that exhibit current dependency, for example inductors with cores

*Not available for the 3504 series.

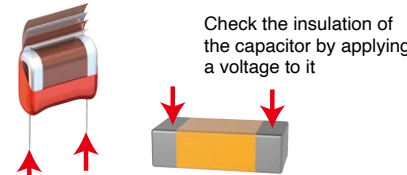


C measurement range	0.000 fF to 15.0000 μ F
Measurement voltage (open-circuit voltage)	500 mV, 1 V
Measurement frequency	1 kHz, 1 MHz

Interference when using multiple instruments



Measurement frequency interference occurs when multiple instruments are used at the same time on a production line. The measurement frequency shift function* ($\pm 1\%$, $\pm 2\%$) facilitates stable measurement by shifting measurement frequencies.

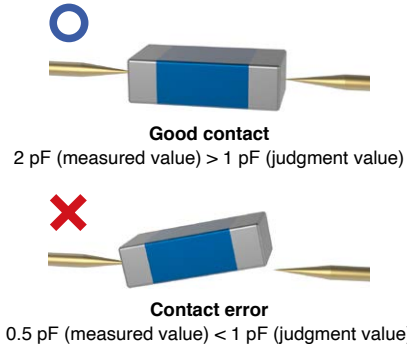


SM7110	SM7120	SM7420
Number of channels		
1 ch	1 ch	4 ch
Test voltage		
0.1 V to 1000.0 V	0.1 V to 2000.0 V	-

Determining the measurement probe contact

The instrument can determine the contact status by measuring capacitance and comparing the result to a previously-set judgment value.

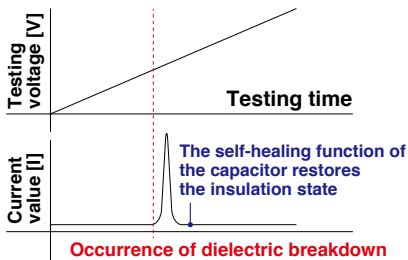
Judgment value setting:
1 pF (can be set as low as 0.2 pF)



Test voltage
0.20 kV to 5.00 kV AC
0.20 kV to 5.00 kV DC
Test time
0.1 sec. to 99.9 sec.

Testing the self-healing functions of film capacitors

The self-healing function can be tested by gradually increasing the test voltage.



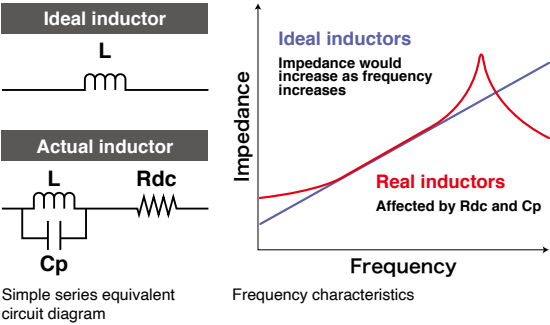
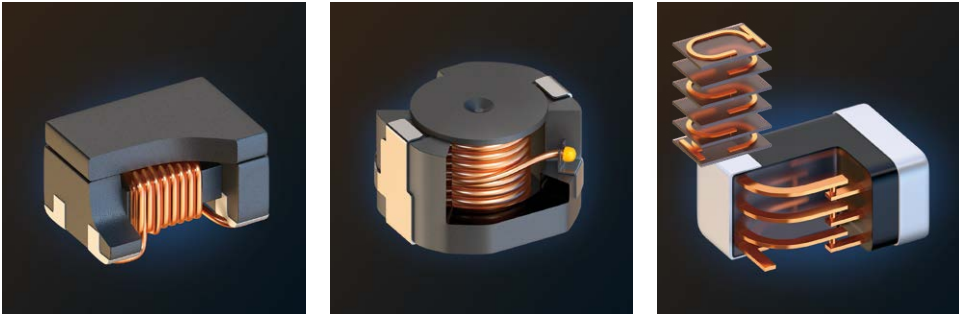
Self-healing function:

Function that instantaneously restores the insulated state, even if the insulation breakdown occurs

Film capacitors are primarily used in power supply circuits to smooth the supply of power. Because the integrity of the insulation in capacitors has a significant impact on component safety, standards such as IEC 60384-14 have been defined to address the risk of fire and electric shock hazards.

IEC 60384-14: An international standard that outlines safety performance such as the voltage endurance and flame resistance of capacitors connected to commercial power supplies from the perspective of preventing hazards caused by electricity leaks, including fire and electric shock.

Inductors



DC resistance Rdc (DCR)
An ideal coil would be an element that has only inductance (L). In reality however, coils have resistance from the winding wire and coil, Rdc, as well as capacitance between the winding wires, Cp.

Loss coefficient Q (quality factor)
Q is an important quality indicator for high-frequency coils. Larger values indicate less power loss and therefore higher-quality coils.

IM7580s Series
Measurement parameters:
Z, Y, θ , Rs, Rp, X, G, B, Cs, Cp, Ls, Lp, D, Q

IM3570
Measurement parameters:
Z, Y, θ , Rs, Rp, X, Rdc, G, B, Cs, Cp, Ls, Lp, D, Q

Impedance Analyzers

Checking frequency characteristics

Check frequency characteristics by making measurements while sweeping through a range of frequencies. The IM7580s series and IM3570 can simultaneously perform sweep measurement for two or four parameters, respectively.

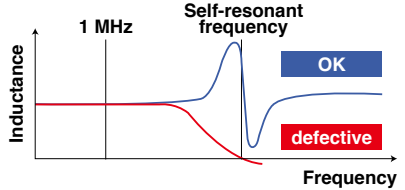
Model	Measurement frequency
IM3570	4 Hz to 5 MHz
IM7580A	1 MHz to 300 MHz
IM7581	100 kHz to 300 MHz
IM7583	1 MHz to 600 MHz
IM7585	1 MHz to 1.3 GHz
IM7587	1 MHz to 3 GHz

Generating pass and fail judgments based on user-defined values
Generate pass and fail judgments based on whether coils satisfy required specifications.

Area judgment
User-specified judgment threshold of the full frequency sweep

Spot judgment
User-specified judgment thresholds of user-specified frequencies

Detecting minuscule shorts between winding wires and the core
Checking inductance frequency characteristics up to the vicinity of the self-resonant frequency can reveal differences between non-defective parts and parts with shorts.



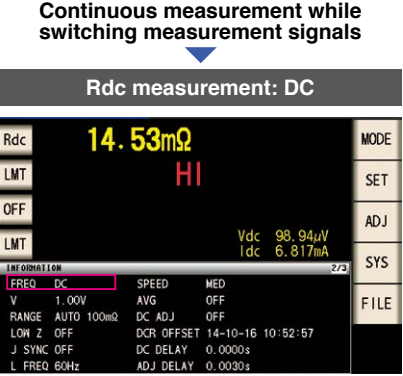
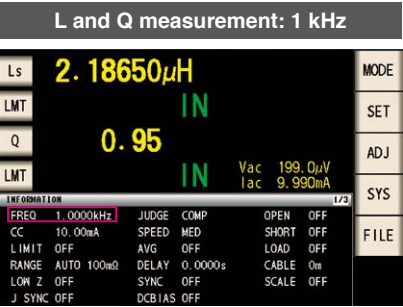
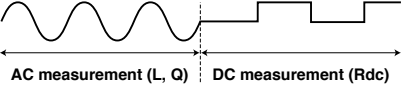
IM3533
Measurement frequency: 1 mHz to 200 kHz
Measurement parameters:
Z, Y, θ , Rs, Rp, X, Rdc, G, B, Cs, Cp, Ls, Lp, D, Q, N, M, ΔL , T

IM3536
Measurement frequency: 4 Hz to 8 MHz
Measurement parameters:
Z, Y, θ , Rs, Rp, X, Rdc, G, B, Cs, Cp, Ls, Lp, D, ϵ , σ

LCR Meters

Measuring L, Q, and Rdc

The IM3533 and IM3536 can make measurements while switching between AC and DC signals. The instruments can measure L and Q using an AC signal and Rdc using a DC signal.



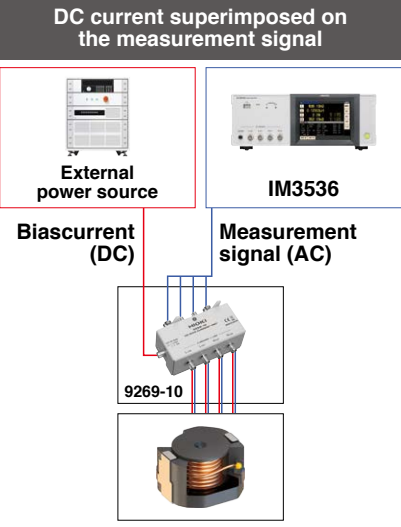
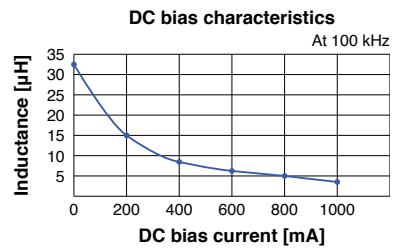
9269-10
Measurement frequency: 40 Hz to 2 MHz
Maximum applied current at frequency: 2 A DC
Connect between fixture and instrument.

IM3536
Measurement frequency: 4 Hz to 8 MHz
Measurement parameters:
Z, Y, θ , Rs, Rp, X, Rdc, G, B, Cs, Cp, Ls, Lp, D, ϵ , σ

LCR Meters

Measuring DC bias

DC bias can affect L values. The IM3536 and 9269-10 can be used with an external power source to superimpose a DC current on the measurement signal and measure a coil's L value.



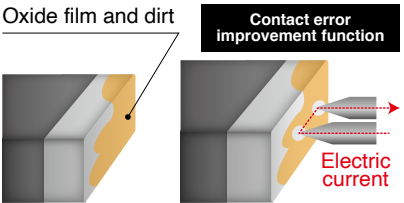
RM3542A
Resistance measurement range:
0.0000 m Ω to 120.0000 M Ω (LOW POWER OFF)*
0.000 m Ω to 1200.000 Ω (LOW POWER ON)*
Measurement current: 100 mA DC to 100 nA DC

Resistance Meters

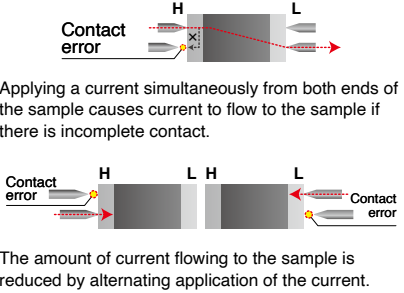
Measuring the Rdc of ferrite beads at high speed

The RM3542A can measure the Rdc of ferrite beads in as little as 0.9 ms.

Increasing productivity by addressing contact errors
Oxide film and dirt between the probes and sample can result in incomplete contact, causing a contact error. The RM3542A addresses this issue by applying a current to destroy oxide film and dirt.



Anticipating changes in ferrite bead characteristics
Applying a current to ferrite (a magnetic material) affects the material's characteristics. The amount of current flowing to the sample can be reduced by alternately applying a current to destroy oxide films and dirt.

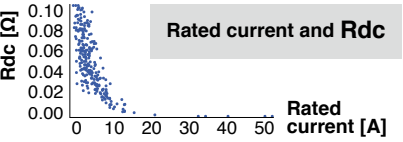


RM3545
Resistance measurement range:
0.00000 m Ω to 1200.0 M Ω
Measurement current: 1 A DC to 100 nA DC

Resistance Meters

Measuring low Rdc at high accuracy

Low-Rdc inductors are becoming more common as a way to reduce energy loss. The RM3545 can measure low Rdc at high accuracy and high resolution.



High-accuracy measurement

Range	Basic accuracy	Measurement current
10 m Ω	$\pm 0.060\%$ rdg. + 0.001% f.s.	1 A
100 m Ω	$\pm 0.014\%$ rdg. + 0.001% f.s.	1 A, 100 mA
1000 m Ω	$\pm 0.008\%$ rdg. + 0.002% f.s.	100 mA, 10 mA
10 Ω	$\pm 0.008\%$ rdg. + 0.001% f.s.	10 mA, 1 mA
100 Ω	$\pm 0.007\%$ rdg. + 0.001% f.s.	10 mA, 1 mA
1000 Ω	$\pm 0.006\%$ rdg. + 0.001% f.s.	1 mA
10 k Ω	$\pm 0.007\%$ rdg. + 0.001% f.s.	1 mA
100 k Ω	$\pm 0.007\%$ rdg. + 0.001% f.s.	100 μ A
1000 k Ω	$\pm 0.008\%$ rdg. + 0.001% f.s.	10 μ A
10 M Ω	$\pm 0.030\%$ rdg. + 0.001% f.s.	1 μ A
100 M Ω	$\pm 0.200\%$ rdg. + 0.001% f.s.	100 nA, 1 μ A or less
1000 M Ω	$\pm 1.00\%$ rdg. + 0.02% f.s.	1 μ A or less

High resolution

Range	Resolution	Max. display
10 m Ω	10 n Ω	12,000.00 m Ω
100 m Ω	100 n Ω	120,000.0 m Ω
1000 m Ω	1 $\mu\Omega$	1200,000 m Ω
10 Ω	10 $\mu\Omega$	12,000.00 Ω
100 Ω	100 $\mu\Omega$	120,000.0 Ω
1000 Ω	1 m Ω	1200,000 Ω
10 k Ω	10 m Ω	12,000.00 k Ω
100 k Ω	100 m Ω	120,000.0 k Ω
1000 k Ω	1 Ω	1200,000 k Ω
10 M Ω	10 Ω	12,000.00 M Ω
100 M Ω	10 k Ω	120,000.0 M Ω
1000 M Ω	100 k Ω	1200.0 M Ω

SM7110
Test voltage: 0.1 V to 1000.0 V

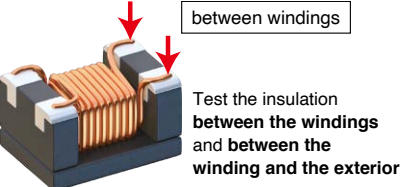
SM7120
Test voltage: 0.1 V to 2000.0 V

SM7420
Test voltage: varies with external power source

Super Megohm Meters

Evaluating insulation resistance while applying a high voltage

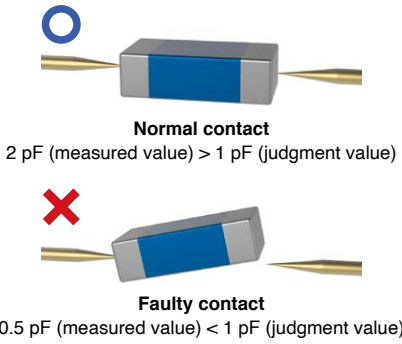
The SM7110 and SM7120 can test insulation at voltages of up to 1000 V or 2000 V, respectively. The SM7420 can test insulation across 4 channels when used with an external power source to shorten test cycle times.



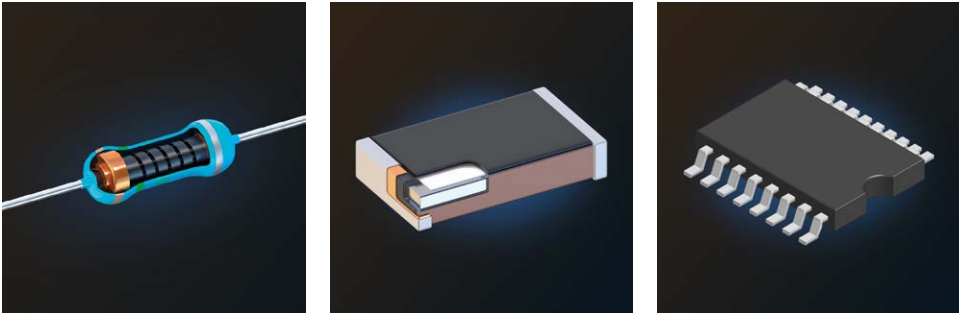
SM7110	SM7120	SM7420
Number of channels		
1 ch	1 ch	4 ch
Test voltage		
0.1 V to 1000.0 V	0.1 V to 2000.0 V	-

Determining the measurement probe contact
The status of contact is determined by measuring capacitance and comparing the result to a previously-set judgment value.

When judgment value is 1 pF (can be set as low as 0.2 pF)



Resistors

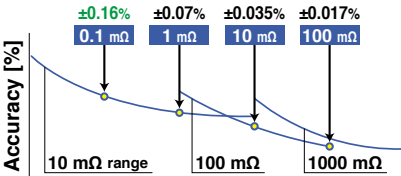


RM3543
Resistance measurement range:
0.00000 mΩ to 1200.000 Ω
Measurement current: 1 A DC to 1 mA DC

Resistance Meters

Measuring low Rdc with high accuracy

The RM3543 can perform measurements with high accuracy (0.1 mΩ ±0.16%) and high resolution (0.01 μΩ).



Accuracy of each range

High-accuracy measurement

Range	Basic accuracy	Measurement current
10 mΩ	±0.060% rdg. +0.001% f.s.*1	1 A
100 mΩ	±0.060% rdg. +0.001% f.s.*2	1 A, 100 mA
1000 mΩ	±0.012% rdg. +0.001% f.s.	100 mA
10 Ω	±0.008% rdg. +0.001% f.s.	10 mA
100 Ω	±0.007% rdg. +0.001% f.s.	10 mA
1000 Ω	±0.006% rdg. +0.001% f.s.	1 mA

*1: With averaging enabled and set to 16 or more iterations
*2: Measurement current: 1 A

High resolution

Range	Resolution	Max. display
10 mΩ	10 nΩ	12.000 00 mΩ
100 mΩ	100 nΩ	120.000 0 mΩ
1000 mΩ	1 μΩ	1200.000 mΩ
10 Ω	10 μΩ	12.000 00 Ω
100 Ω	100 μΩ	120.000 0 Ω
1000 Ω	1 mΩ	1200.000 Ω



RM3542A
Resistance measurement range:
0.0000 mΩ to 120.0000 MΩ
Measurement current: 100 mA DC to 100 nA DC

Special specifications are available to measure resistances of about 100 MΩ with high accuracy (less than 500 ppm)

Resistance Meters

Measuring high Rdc with high accuracy

The RM3542A includes a 100 MΩ range that allows accurate measurement of high Rdc.



Z3003
4-terminal measurement: 10 ch
2-terminal measurement: 21 ch

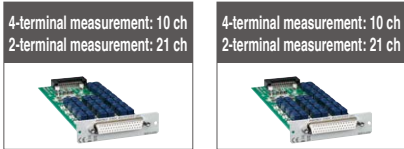


RM3545-02
Resistance measurement range:
0.00000 mΩ to 1200.0 MΩ
Measurement current: 1 A DC to 100 nA DC

Resistance Meters

Generating pass and fail judgments for multiple channels

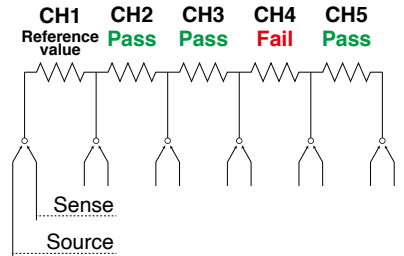
The Z3003 (sold separately) can be installed on the RM3545-02 to increase the number of measurement channels. Additionally, measurement results for channel 1 can be used as reference values to generate pass and fail judgments based on the measurement results for subsequent channels.



Z3003: Two units can be installed

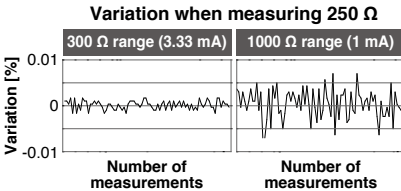
Generating pass and fail judgments for network resistance

Network components are composite components that group multiple resistors together into a single package. One resistor in the network resistance can be used as a reference to generate pass and fail judgments for the other resistors.



High repeatability

The instrument applies an appropriate measurement current based on the resistance value of the resistor under measurement. The instrument delivers high repeatability and is ideally suited for use in shipping inspections of resistors with low nominal value tolerances.



Other electronic components

Thermistors and resettable fuses

Thermistors are characterized by a resistance value that changes in response to temperature variations. Drawing on this characteristic, thermistors are primarily used as temperature sensors.

Resistance Meters



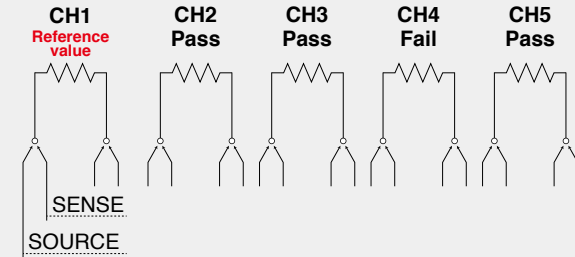
RM3545-02
Resistance measurement range: 0.00000 mΩ to 1200.0 MΩ
Measurement current: 1 A DC to 100 nA DC



4-terminal measurement: 10 ch
2-terminal measurement: 21 ch

Generating pass and fail judgments without temperature compensation

When used with the Z3003 Multiplexer Unit, The RM3545-02 can use previously measured values as a master reference sample connected to channel 1 to generate pass and fail judgments based on the measurement results for subsequent channels. Since measured values for channel 1 serve as the reference values for generating those judgments, there's no need to perform temperature correction.



Piezoelectric elements

Applying pressure or vibration to a piezoelectric element generates a voltage. Conversely, applying a voltage causes the piezoelectric material to deform in shape. Drawing on this characteristic, piezoelectric elements are used in vibration sensors and actuators.

Impedance Analyzers



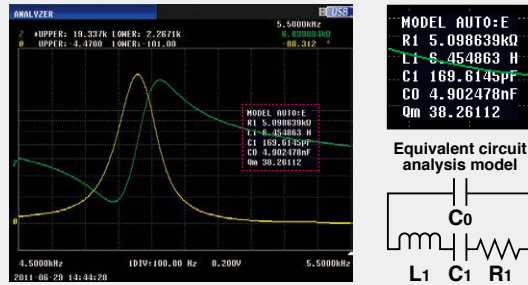
IM7580s Series



IM3570 + IM9000

Analyzing the characteristics of piezoelectric elements

The equivalent circuit analysis function can be used to analyze individual elements in an equivalent circuit model. It can also be used to calculate resonant and antiresonant frequencies.



Varistors

When a voltage that is equal to or greater than a certain value is applied to a varistor, the varistor's resistance decreases. Drawing on this characteristic, varistors are used to protect circuits by routing electricity to the ground in the event of an abnormal voltage such as a surge voltage or static electricity.

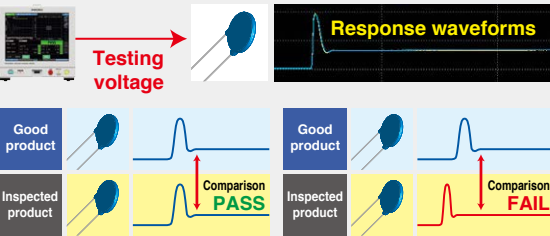
Impulse Winding Testers



ST4030A
Testing voltage: 100 V to 4200 V
Testing voltage: special specifications available for 100 V or less

Impulse testing

Impulse testers can be used to test whether a varistor functions at the defined voltage. The ST4030A can record a response waveform while applying a user-specified voltage. The response waveform from a known-good part can be used as a master/reference waveform to generate pass and fail judgments.



Substrate materials

A variety of substrate materials are available. For equipment such as communications components used to exchange information at high speeds, it's essential to use substrate materials with low permittivity so that losses that occur during information transmission can be minimized.

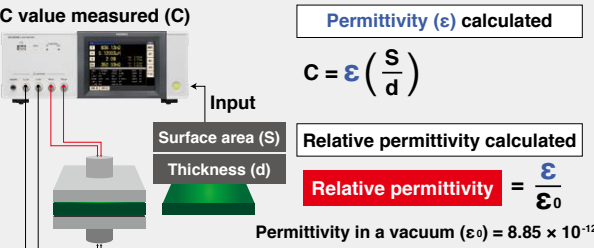
LCR Meters



IM3536

Measuring permittivity

The IM3536 can measure permittivity if the sample's diameter and thickness are specified.



Probes and test fixtures for LCR Meters and Impedance Analyzers

For leaded components				Compatible products
1	4-TERMINAL PROBE	L2000	Cable length 1 m (3.28 ft.), DC to 8 MHz, measurable terminal diameter 0.3 to 5 mm (0.012 to 0.19 in.)	IM3533, IM3536, IM3570
2	4-TERMINAL PROBE	9140-10	Cable length 1 m (3.28 ft.), DC to 200 kHz, measurable terminal diameter 0.3 to 5 mm (0.012 to 0.19 in.)	IM3533, IM3536, IM3570
3	4-TERMINAL PROBE	9140	Cable length 1 m (3.28 ft.), DC to 100 kHz, measurable terminal diameter 0.3 to 5 mm (0.012 to 0.19 in.)	IM3533, IM3536, IM3570
4	4-TERMINAL PROBE	9500	Cable length 1 m (3.28 ft.), DC to 1 MHz, measurable terminal diameter 0.3 to 2 mm (0.012 to 0.078 in.)	IM3533, IM3536, IM3570
5	4-TERMINAL PROBE	9500-10	Cable length 1 m (3.28 ft.), DC to 200 kHz, measurable terminal diameter 0.3 to 2 mm (0.012 to 0.078 in.)	IM3533, IM3536, IM3570
6	TEST FIXTURE	9261-10	Cable length 1 m (3.28 ft.), DC to 8 MHz, measurable terminal diameter 0.3 to 1.5 mm (0.012 to 0.059 in.)	IM3533, IM3536, IM3570
7	TEST FIXTURE	9261	Cable length 1 m (3.28 ft.), DC to 5 MHz, measurable terminal diameter 0.3 to 1.5 mm (0.012 to 0.059 in.)	IM3533, IM3536, IM3570
8	TEST FIXTURE	9262	Direct connection type, DC to 8 MHz, measurable terminal diameter 0.3 to 2 mm (0.012 to 0.078 in.)	IM3533, IM3536, IM3570



L2000



9140-10



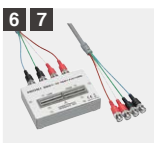
9140



9500



9500-10



9261/9261-10



9262

For surface mounting devices (SMD)				Compatible products
1	TEST FIXTURE STAND	IM9200	Use with IM9201 and IM9202	IM7580s series
2	TEST FIXTURE	IM9201	DC to 3 GHz	IM7580s series
3	TEST FIXTURE	IM9202	DC to 600 MHz	IM7580s series
4	ADAPTER	IM9906	3.5 (male) to 7 mm (0.138 to 0.276 in.) converter	IM7580s series
5	CALIBRATION KIT	IM9905	Set of OPEN, SHORT and LOAD	IM7580s series
6	SMD TEST FIXTURE	IM9110	Direct connection type, DC to 1 MHz	IM3533, IM3536, IM3570, IM7580s series
7	SMD TEST FIXTURE	IM9100	Direct connection type, DC to 8 MHz, for SMDs with electrode on bottom	IM3533, IM3536, IM3570, IM7580s series
8	SMD TEST FIXTURE	9699	Direct connection type, DC to 120 MHz, for SMDs with electrode on bottom	IM3533, IM3536, IM3570
9	SMD TEST FIXTURE	9677	Direct connection type, DC to 120 MHz, for SMDs with electrode on side	IM3533, IM3536, IM3570
10	SMD TEST FIXTURE	9263	Direct connection type, DC to 8 MHz	IM3533, IM3536, IM3570
11	PINCHER PROBE	L2001	Cable length 73 cm (28.74 in.), DC to 8 MHz, includes IM9901	IM3533, IM3536, IM3570
12	CONTACT TIPS	IM9901	For L2001 tip conversion	-
13	CONTACT TIPS	IM9902	For L2001 tip conversion	-



IM9200



IM9201



IM9202



IM9906



IM9905



IM9110



IM9100



9699



9677



9263



L2001



IM9901



IM9902

DUT size: Can the DUT size be measured?

***It may not be possible to measure depending on the shape.**

EIA (in)	JIS (mm)	Lengths (mm)	width (mm)	IM9201	IM9202	IM9110	IM9100	9699	9677	9263	L2001 IM9901	L2001 IM9902
-	0201	0.25	0.125			Yes						
01005	0402	0.40	0.20				Yes					
0201	0603	0.60	0.30	Yes			Yes		Yes*			Yes
0402	1005	1.00	0.50	Yes			Yes		Yes			Yes
0603	1608	1.60	0.80	Yes	Yes			Yes	Yes	Yes*	Yes	Yes
0805	2012	2.00	1.25	Yes	Yes			Yes	Yes*	Yes	Yes	Yes
1206	3216	3.20	1.60	Yes	Yes			Yes*		Yes	Yes	Yes
1210	3225	3.20	2.50	Yes	Yes			Yes*		Yes	Yes	Yes
1812	4532	4.50	3.20		Yes					Yes	Yes	Yes
2220	5750	5.70	5.00		Yes					Yes	Yes	Yes

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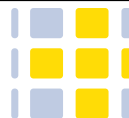
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